Seal	rch i	Note	es

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/707,690	ZHU ET AL.	
Examiner	Art Unit	
DAVID VU	2818	

SEARCHED			
Class	Subclass	Date	Examiner
257	192, 347; 353, 401; 619, 623	9/15/2006	DV
	E21.422	9/15/2006	DV
	E29.056	9/15/2006	DV
	E29.275	9/15/2006	DV
	E29.298	9/15/2006	DV
	E29.299	9/15/2006	DV
Updated		3/10/2007	DV

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
All	Above	3/10/2007	DV
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	DATE	EXMR
EAST	9/15/200	06 DV
EAST	9/15/200	06 DV
EAST	3/10/200)7 DV